

| Search Notes<br> | Application/Control No. | Applicant(s)/Patent under Reexamination |
|--|-------------------------|---|
|  | 10/002,265              | SHELEST ET AL.                          |
|  | Examiner                | Art Unit                                |
|  | Eric Kuiper             | 2154                                    |

| SEARCH NOTES<br>(INCLUDING SEARCH STRATEGY)            |           |      |
|--|-----------|------|
|  | DATE      | EXMR |
| Performed Inventor Search                              | 3/12/2006 | EJK  |
| Searched EAST Databases<br>See attached Search History | 3/15/2006 | EJK  |
| Conducted PLUS Search                                  | 2/23/2006 | EJK  |
| Searched IEEE Xplore Database                          | 3/15/2006 | EJK  |
| Searched INSPEC Database                               | 3/15/2006 | EJK  |
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|  |           |      |
|  |           |      |

| INTERFERENCE SEARCHED |          |      |          |
|-----------------------|----------|------|----------|
| Class                 | Subclass | Date | Examiner |
|                       |          |      |          |
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